

| | | | | |
|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/599,458 | | Applicant(s)/Patent Under Reexamination SAITO ET AL. | |
| | Examiner Hai Phan | | Art Unit 2614 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-6,725,027 B1 | 04-2004 | Tsuji et al. | 455/296 |
| * | B | US-6,795,559 B1 | 09-2004 | Taura et al. | 381/94.8 |
| * | C | US-6,826,392 B2 | 11-2004 | Tsuji et al. | 455/296 |
| * | D | US-2005/0143109 A1 | 06-2005 | Ohashi, Toru | 455/501 |
| * | E | US-2009/0147891 A1 | 06-2009 | Furukawa, Hiroki | 375/346 |
| * | F | US-7,542,748 B2 | 06-2009 | Saito et al. | 455/205 |
| * | G | US-7,551,743 B1 | 06-2009 | Tsujishita et al. | 381/94.1 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | I | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.